



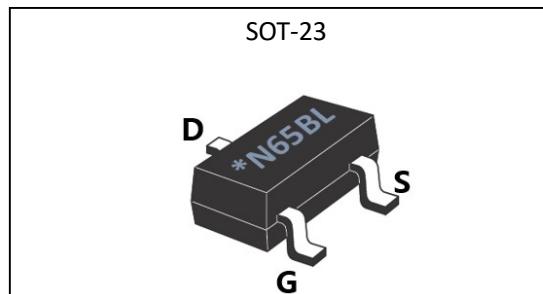
GL1N65BL

Silicon N-Channel Power MOSFET

General Description:

GL1N65BL the silicon N-channel Enhanced VDMOSFET, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is SOT-23L, which accords with the RoHS standard.

V_{DSS}	650	V
I_D	0.5	A
$P_D(T_C=25^\circ\text{C})$	1.0	W
$R_{DS(\text{ON}),\text{TYP.}}$	28	Ω

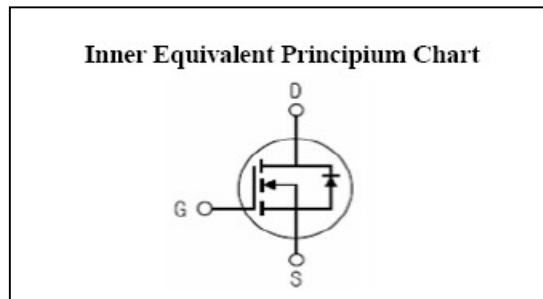


Features:

- Fast Switching
- Low ON Resistance($R_{ds(on)} \leq 33\Omega$)
- Low Gate Charge (Typical Data: 5 nC)
- Low Reverse transfer capacitances(Typical: 2.8pF)
- Low V_{th} (Typical: 1.0V)

Applications:

- Power switch circuit of adaptor and charger



Absolute ($T_C=25^\circ\text{C}$ unless otherwise specified):

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-to-Source Voltage	650	V
I_D	Continuous Drain Current	0.5	A
	Continuous Drain Current $T_C=100^\circ\text{C}$	0.4	A
I_{DM}^{a1}	Pulsed Drain Current	2.0	A
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{As}^{a2}	Single Pulse Avalanche Energy	12	mJ
E_{Ar}^{a1}	Avalanche Energy ,Repetitive	3	mJ
I_{AR}^{a1}	Avalanche Current	0.5	A
dv/dt^{a3}	Peak Diode Recovery dv/dt	5.0	V/ns
P_D	Power Dissipation	1	W
T_J, T_{stg}	Operating Junction and Storage Temperature Range	150, -55 to 150	$^\circ\text{C}$
T_L	Maximum Temperature for Soldering	300	$^\circ\text{C}$

Caution Stresses greater than those in the "Absolute Maximum Ratings" may cause permanent damage to the device



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Thermal Characteristics

Symbol	Parameter	Rating	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	125	°C / W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	70	°C / W

Electrical Characteristics ($T_c = 25^\circ C$ unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
V_{DSS}	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	650	--	--	V
$\Delta V_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D=250\mu A$, Reference $25^\circ C$	--	0.51	--	$V/^\circ C$
$I_{DS(on)}$	Drain to Source Leakage Current	$V_{DS}=650V, V_{GS}=0V, T_a=25^\circ C$	--	--	1	μA
		$V_{DS}=520V, V_{GS}=0V, T_a=125^\circ C$	--	--	100	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+25V$	--	--	1000	nA
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-25V$	--	--	-1000	nA

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(on)}$	Drain-to-Source On-Resistance	$V_{GS}=10V, I_D=0.3A$	--	27	33	Ω
$R_{DS(on)}$	Drain-to-Source On-Resistance	$V_{GS}=4.5V, I_D=0.1A$	--	28	34	Ω
$R_{DS(on)}$	Drain-to-Source On-Resistance	$V_{GS}=3V, I_D=0.1A$	--	29	35	Ω
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	0.5	--	1.5	V
g_{fs}	Forward Trans conductance	$V_{DS}=15V, I_D=0.5A$	--	0.4	--	S

Pulse width < 380μs; duty cycle < 2%.

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
C_{iss}	Input Capacitance	$V_{GS}=0V, V_{DS}=25V$	--	80	--	pF
C_{oss}	Output Capacitance	$f=1.0MHz$	--	8	--	
C_{rss}	Reverse Transfer Capacitance		--	2.8	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(on)}$	Turn-on Delay Time	$I_D=0.8A, V_{DD}=350V$	--	7.3	--	ns
t_r	Rise Time		--	6	--	
$t_{d(off)}$	Turn-Off Delay Time		--	21	--	
t_f	Fall Time		--	15.5	--	
Q_g	Total Gate Charge	$I_D=0.8A, V_{DD}=350V$	--	4.3	--	nC



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Q _{gs}	Gate to Source Charge	V _{GS} =10V	--	0.56	--	
Q _{gd}	Gate to Drain ("Miller")Charge		--	2.1	--	

Source-Drain Diode Characteristics

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
I _{SD}	Continuous Source Current (Body Diode)		--	--	0.5	A
I _{SM}	Maximum Pulsed Current (Body Diode)		--	--	2	A
V _{SD}	Diode Forward Voltage	I _S =0.5A,V _{GS} =0V	--	--	1.5	V
t _{rr}	Reverse Recovery Time	I _S =0.5A,T _j =25°C	--	374	--	ns
Q _{rr}	Reverse Recovery Charge	dI _F /dt=100A/μs,V _{GS} =0V	--	735	--	μC

a1: Repetitive rating; pulse width limited by maximum junction temperature

a2: L=10mH, I_D=1A, Start T_J=25°C

a3: I_{SD}=0.5A,di/dt ≤100A/μs,V_{DD}≤BV_{DS}, Start T_J=25°C

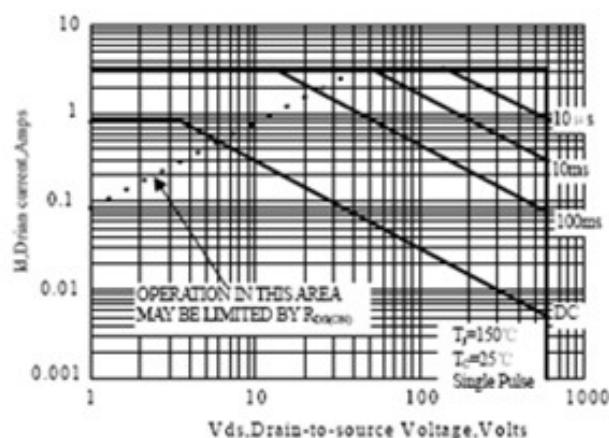
Characteristics Curve:


Figure 1 Maximum Forward Bias Safe Operating Area

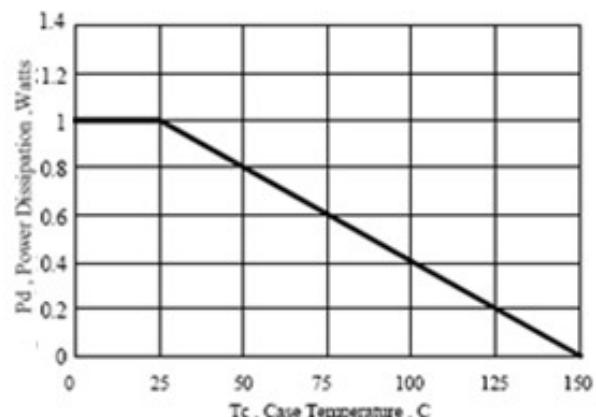


Figure 2 Maximum Power Dissipation vs Case Temperature

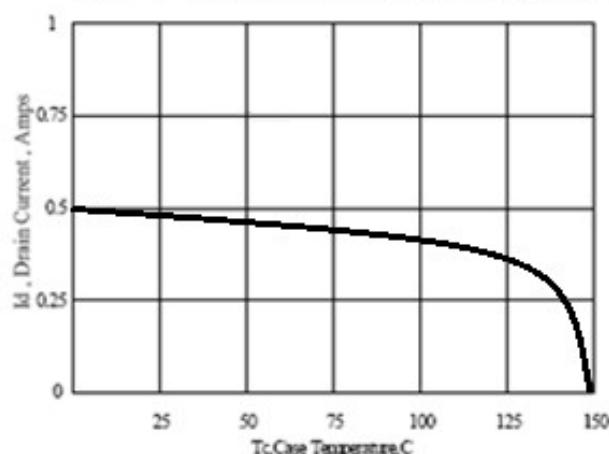


Figure 3 Maximum Continuous Drain Current vs Case Temperature

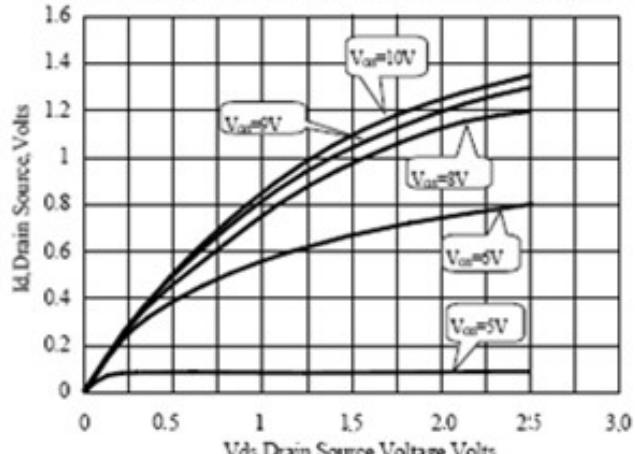


Figure 4 Typical Output Characteristics

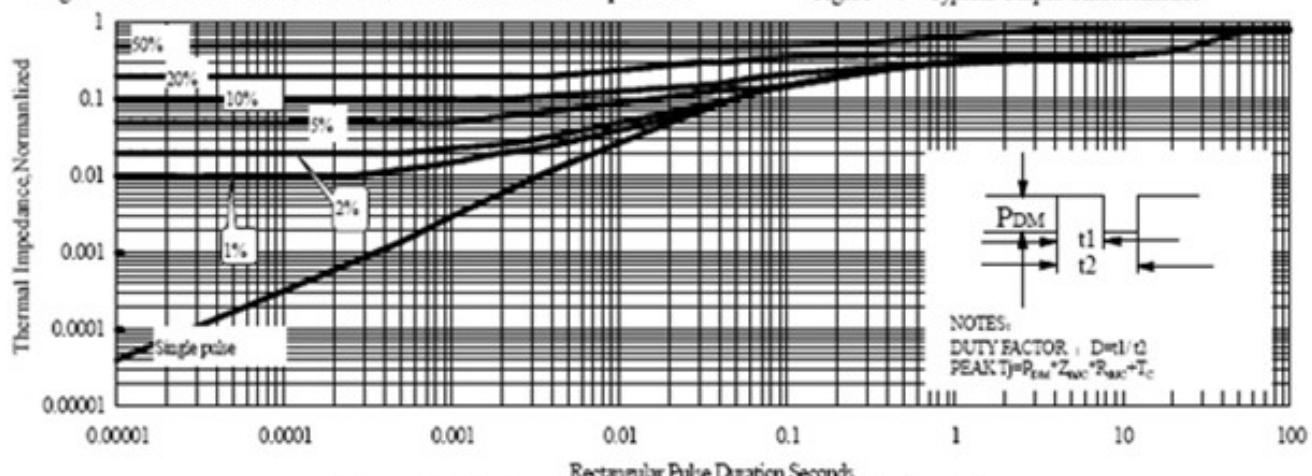


Figure 5 Maximum Effective Thermal Impedance, Junction to Case

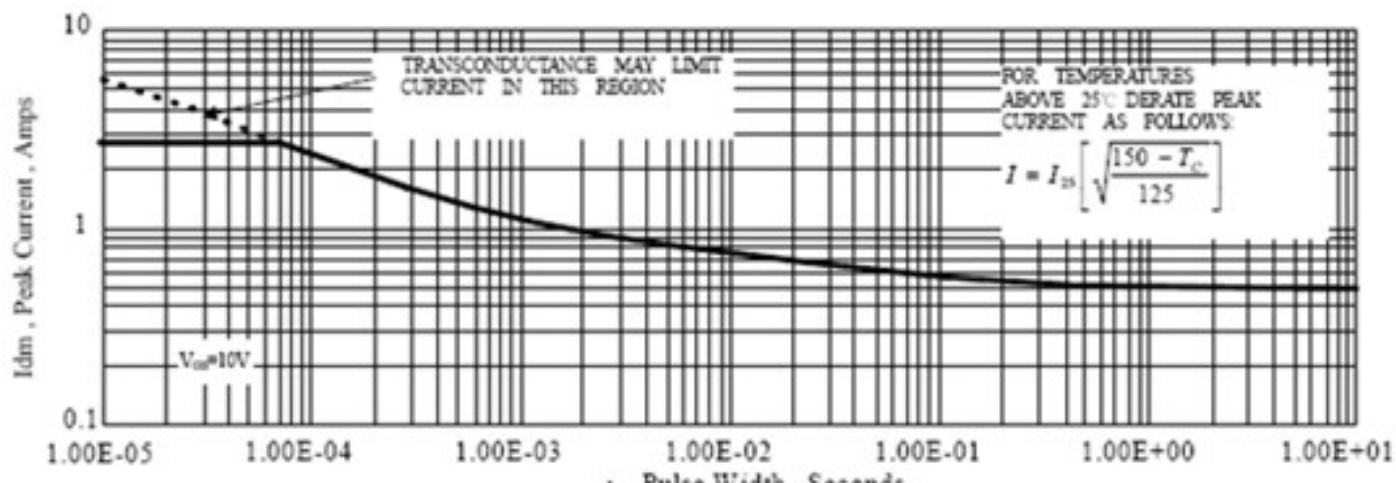


Figure 6 Maximum Peak Current Capability

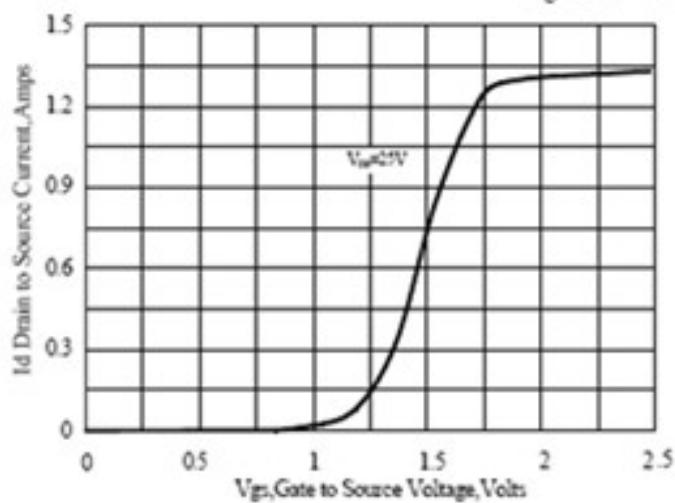


Figure 7 Typical Transfer Characteristics

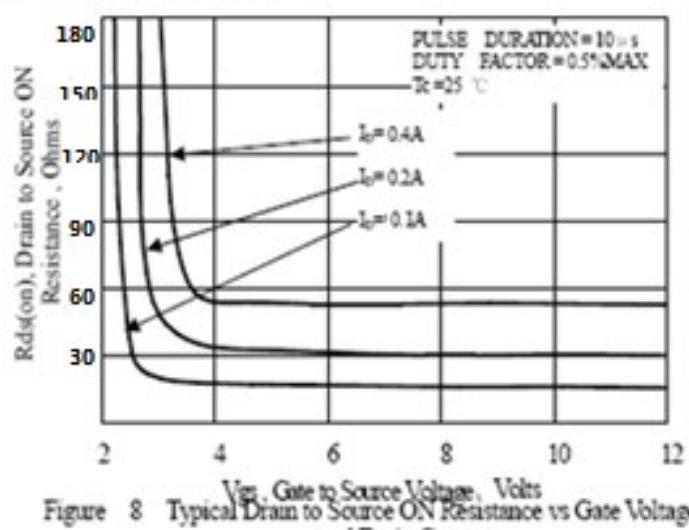


Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

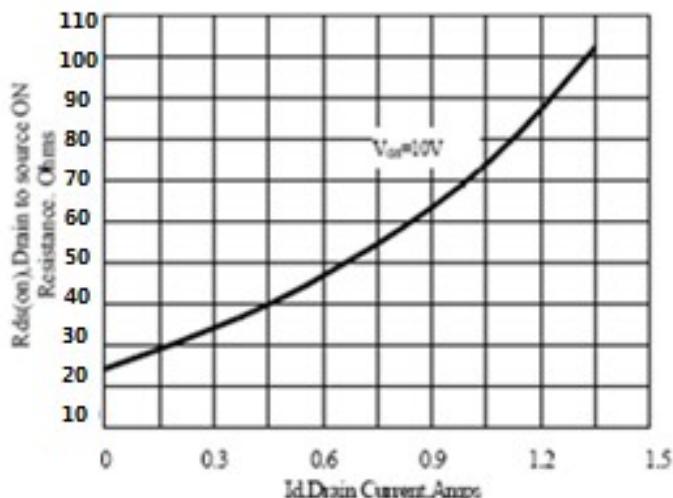


Figure 9 Typical Drain to Source ON Resistance vs Drain Current

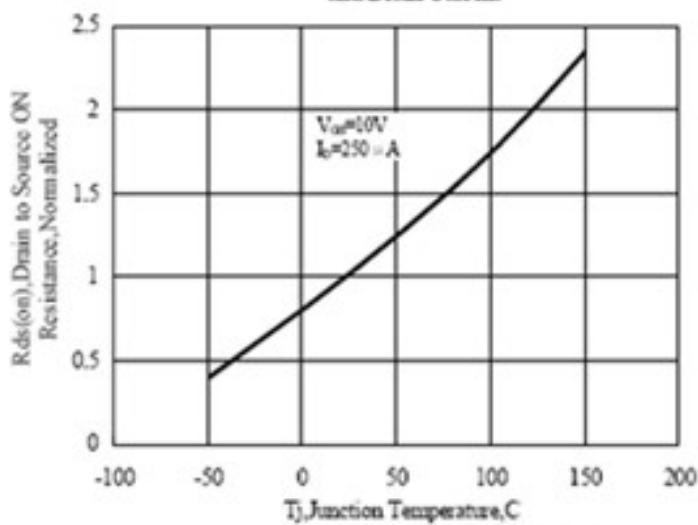


Figure 10 Typical Drain to Source on Resistance vs Junction Temperature



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